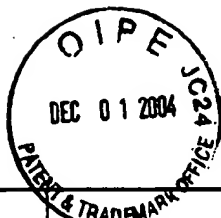


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PTO/SB/08A (08-00)

Substitute for form 1449B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(use as many sheets as necessary)</i>				Complete if Known	
				Application Number	09/844,271
				Filing Date	April 30, 2001
				First Named Inventor	THEKKATH
				Group Art Unit	2122
				Examiner Name	Kendall, Chuck
Sheet	1	of	1	Attorney Docket Number	MTEC-007/00US

OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
OK	1	Embedded Trace Macrocell Specification, Rev. 0/0a, ARM IHI 0014C, ARM Ltd. (1999)	

Examiner Signature	Chuck Kendall	Date Considered	12/22/2004
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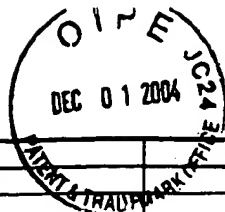


Substitute for form 1449A/PTO		Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(use as many sheets as necessary)</i>		Application Number	09/844,271
		Filing Date	April 30, 2001
		First Named Inventor	THEKKATH
		Group Art Unit	2122
		Examiner Name	Kendall, Chuck
		Attorney Docket Number	MTEC-007/00US
Sheet	1	of	2

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY
		Number	Kind Code ² (if known)		
JE	P1	3,473,154		Couleur et al.	10/14/1969
JE	P2	3,585,599		Hitt	06/15/1971
JE	P3	3,681,534		Burian et al.	08/01/1972
JE	P4	3,702,989		Provenzano, Jr. et al.	11/14/1972
JE	P5	3,704,363		Salmassy et al.	11/28/1972
JE	P6	3,707,725		Dellheim	12/26/1972
JE	P7	3,771,131		Ling	11/06/1973
JE	P8	3,794,831		Frankeny et al.	02/26/1974
JE	P9	3,805,038		Buedel et al.	04/16/1974
JE	P10	3,906,454		Martin	09/16/1975
JE	P11	4,205,370		Hirtle	05/27/1980
JE	P12	4,293,925		Hang et al.	10/06/1981
JE	P13	4,423,508		Shiozaki et al.	12/27/1983
JE	P14	4,462,077		York	07/24/1984
JE	P15	4,503,495		Boudreau	03/05/1985
JE	P16	4,511,960		Boudreau	04/16/1985
JE	P17	4,539,682		Herman et al.	09/03/1985
JE	P18	4,553,223		Bouhelier et al.	11/12/1985
JE	P19	4,554,661		Bannister	11/19/1985
JE	P20	4,590,550		Eilert et al.	05/20/1986
JE	P21	4,742,466		Ochiai et al.	05/03/1988
JE	P22	4,783,762		Inoue et al.	11/08/1988
JE	P23	4,835,675		Kawai	05/30/1989
JE	P24	5,058,114		Kuboki et al.	10/15/1991
JE	P25	5,150,470		Hicks et al.	09/22/1992
JE	P26	5,274,811		Borg et al.	12/28/1993
JE	P27	5,289,587		Razban	02/22/1994
JE	P28	5,404,470		Miyake	04/04/1995
JE	P29	5,434,622		Lim	07/18/1995
JE	P30	5,471,594		Stone	11/28/1995
JE	P31	5,533,193		Roscoe	07/02/1996
JE	P32	5,581,691		Hsu et al.	12/03/1996
JE	P33	5,621,886		Alpert et al.	04/15/1997
JE	P34	5,625,785		Miura et al.	04/29/1997
JE	P35	5,689,636		Kleber et al.	11/18/1997
JE	P36	5,689,694		Funyu	11/18/1997
JE	P37	5,715,435		Ikei	02/03/1998
JE	P38	5,748,904		Huang et al.	05/05/1998
JE	P39	5,751,942		Christensen et al.	05/12/1998
JE	P40	5,812,868		Moyer et al.	09/22/1998
JE	P41	5,832,515		Ledain et al.	11/03/1998
JE	P42	5,878,208		Levine et al.	03/02/1999
JE	P43	5,946,486		Pekowski	08/31/1999
JE	P44	6,009,270		Mann	12/28/1999

¹ Unique citation designation number.

² See attached Kinds of U.S. Patent Documents.



P45	6,012,085	Yohe et al.	01/04/2000
P46	6,106,573	Mahalingaiah et al.	08/22/2000
P47	6,282,701	Wygodny et al.	08/28/2001
P48	6,314,530	Mann	11/06/2001
P49	6,338,159	Alexander	01/08/2002
P50	6,457,144	Eberhard	09/24/2002
P51	6,467,083	Yamashita	10/15/2002
P52	6,487,715	Chamdani et al.	11/26/2002
P53	6,530,076	Ryan et al.	03/04/2003
P54	6,615,370	Edwards et al.	09/02/2003
P55	6,615,371	McCullough et al.	09/02/2003
P56	6,658,649	Bates et al.	12/02/2003
P57	6,684,348	Edwards et al.	01/27/2004
P58	2001/0054175	Watanabe	12/20/2001
P59	2002/0046393	Leino et al.	04/18/2002
P60	2002/0147965	Swaine et al.	10/10/2002

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	T ⁴
		Office ¹	Number ²	Kind Code ³ (if known)			
11	F1	GB	2 329 048		ARM Limited	10/03/1999	
11	F2	GB	2 329 049		ARM Limited	10/03/1999	

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¹ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3).

² For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

³ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible.

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